
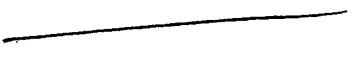

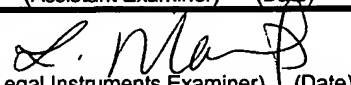


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/774,308	VIEIRA ET AL.	
	Examiner	Art Unit	
	Hanh Phan	2613	

ISSUE CLASSIFICATION									
ORIGINAL			CROSS REFERENCE(S)						
CLASS	SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
398	176		398	175	152	65	79		
INTERNATIONAL CLASSIFICATION			359	326	332	333	330	331	344
H	0	H B	385	1	2	4	5	15	

 (Assistant Examiner) (Date)		 HANH PHAN PRIMARY EXAMINER (Primary Examiner) (Date) <i>09/12/06</i>	Total Claims Allowed: 17	
 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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